

## Description

### JMT Dual N-channel Enhancement Mode Power MOSFET

#### Features

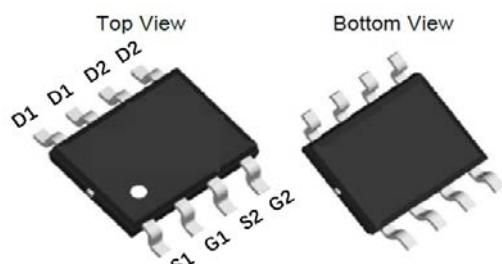
- 30V, 12A
- $R_{DS(ON)} < 11.6\text{m}\Omega$  @  $V_{GS} = 10\text{V}$
- $R_{DS(ON)} < 18.7\text{m}\Omega$  @  $V_{GS} = 4.5\text{V}$
- Advanced Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge
- Lead Free

#### Applications

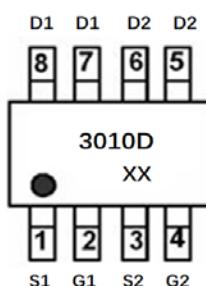
- Load Switch
- PWM Application
- Power Management



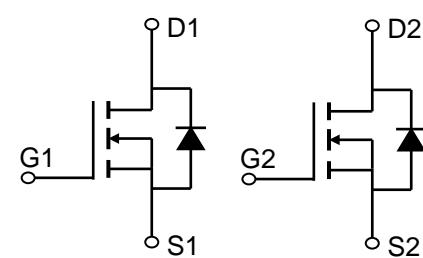
100% UIS TESTED!  
100%  $\Delta V_{ds}$  TESTED!



SOP-8



Marking and Pin Assignment



Schematic Diagram

#### Package Marking and Ordering Information

Device Marking	Device	Outline	Package	Reel Size	Reel(pcs)	Per Carton (pcs)
3010D	JMTP3010D	TAPING	SOP-8	13"	4000	48000

#### Absolute Maximum Ratings (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter		Value	Units
$V_{DS}$	Drain-to-Source Voltage		30	V
$V_{GS}$	Gate-to-Source Voltage		$\pm 20$	V
$I_D$	Continuous Drain Current	$T_A = 25^\circ\text{C}$	12	A
		$T_A = 100^\circ\text{C}$	8	
$I_{DM}$	Pulsed Drain Current <sup>(1)</sup>		48	A
$E_{AS}$	Single Pulsed Avalanche Energy <sup>(2)</sup>		36	mJ
$P_D$	Power Dissipation	$T_A = 25^\circ\text{C}$	1.9	W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient <sup>(3)</sup>		66	$^\circ\text{C}/\text{W}$
$T_J, T_{STG}$	Junction & Storage Temperature Range		-55 to 150	$^\circ\text{C}$

**Electrical Characteristics** ( $T_J = 25^\circ\text{C}$  unless otherwise specified)

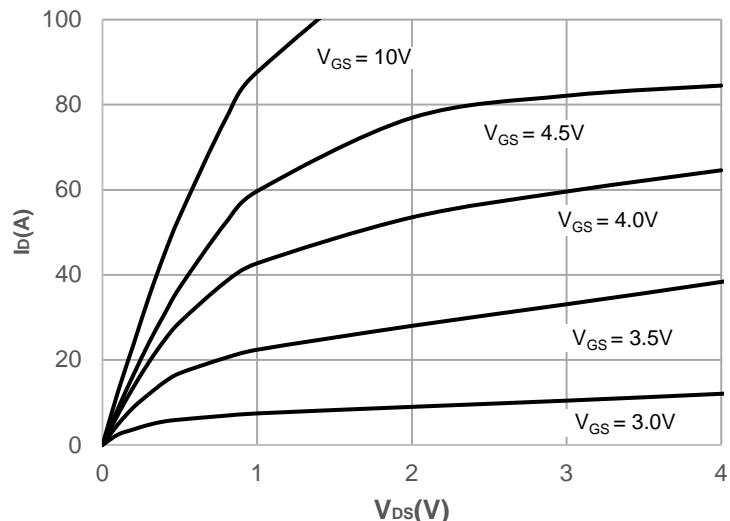
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	30	-	-	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS} = 30\text{V}, V_{GS} = 0\text{V}$	-	-	1.0	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.6	2.2	V
$R_{\text{DS}(\text{ON})}$	Static Drain-Source ON-Resistance <sup>(4)</sup>	$V_{GS} = 10\text{V}, I_D = 12\text{A}$	-	8.9	11.6	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 10\text{A}$	-	14.4	18.7	$\text{m}\Omega$
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 15\text{V}, f = 1\text{MHz}$	-	1002	-	pF
$C_{\text{oss}}$	Output Capacitance		-	131	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	105	-	pF
$Q_g$	Total Gate Charge	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DD} = 15\text{V}, I_D = 12\text{A}$	-	20	-	nC
$Q_{gs}$	Gate Source Charge		-	4	-	nC
$Q_{gd}$	Gate Drain("Miller") Charge		-	5	-	nC
<b>Switching Characteristics</b>						
$t_{d(\text{on})}$	Turn-On Delay Time	$V_{GS} = 10\text{V}, V_{DD} = 15\text{V}$ $I_D = 12\text{A}, R_{\text{GEN}} = 3\Omega$	-	6	-	ns
$t_r$	Turn-On Rise Time		-	19	-	ns
$t_{d(\text{off})}$	Turn-Off Delay Time		-	22	-	ns
$t_f$	Turn-Off Fall Time		-	5	-	ns
<b>Drain-Source Diode Characteristics and Max Ratings</b>						
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	12	-	A
$I_{\text{SM}}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	48	-	A
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 12\text{A}$	-	-	1.2	V
$trr$	Body Diode Reverse Recovery Time	$I_F = 12\text{A}, di/dt = 100\text{A}/\mu\text{s}$	-	8	-	ns
$Qrr$	Body Diode Reverse Recovery Charge		-	2	-	nC

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

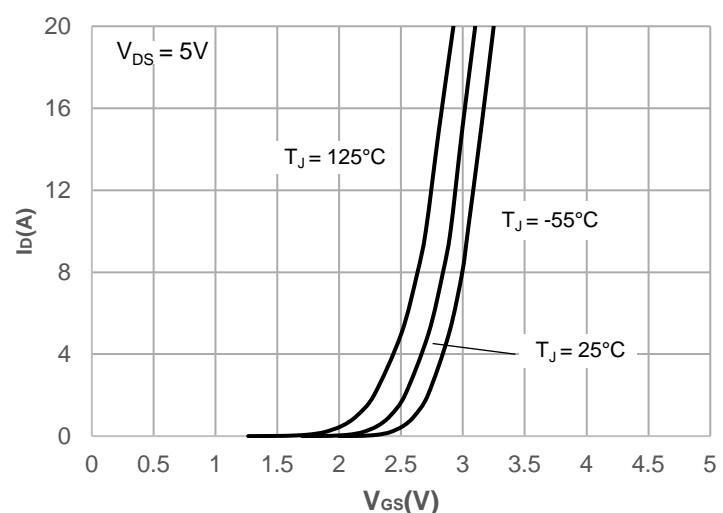
2. E<sub>AS</sub> condition: Starting  $T_J = 25^\circ\text{C}$ ,  $V_{DD} = 15\text{V}$ ,  $V_G = 10\text{V}$ ,  $R_G = 25\text{ohm}$ ,  $L = 0.5\text{mH}$ ,  $I_{AS} = 12\text{A}$ 3.  $R_{\theta JA}$  is measured with the device mounted on a 1inch<sup>2</sup> pad of 2oz copper FR4 PCB4. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$ .

## Typical Performance Characteristics

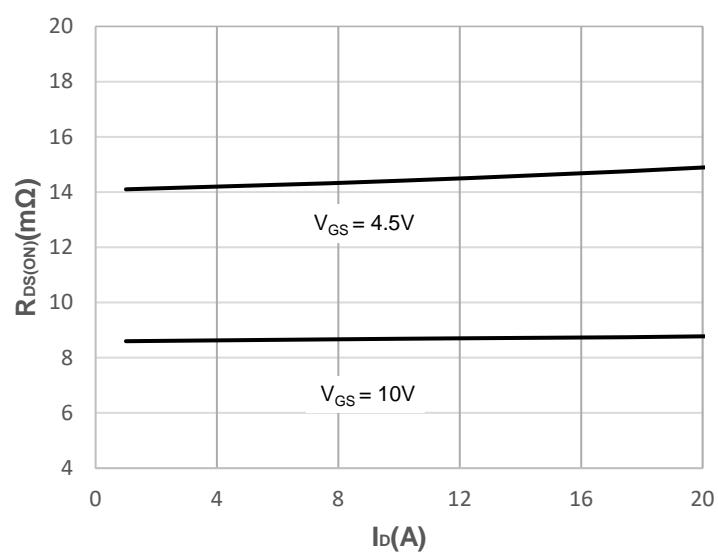
**Figure 1: Output Characteristics**



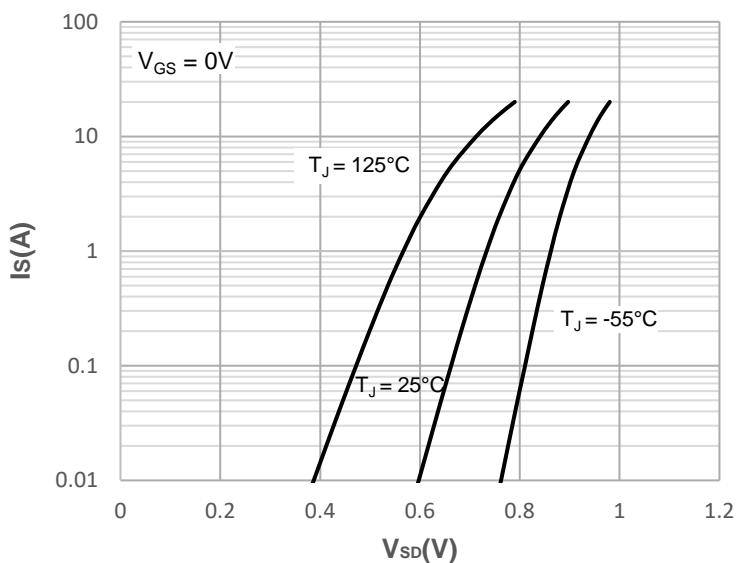
**Figure 2: Typical Transfer Characteristics**



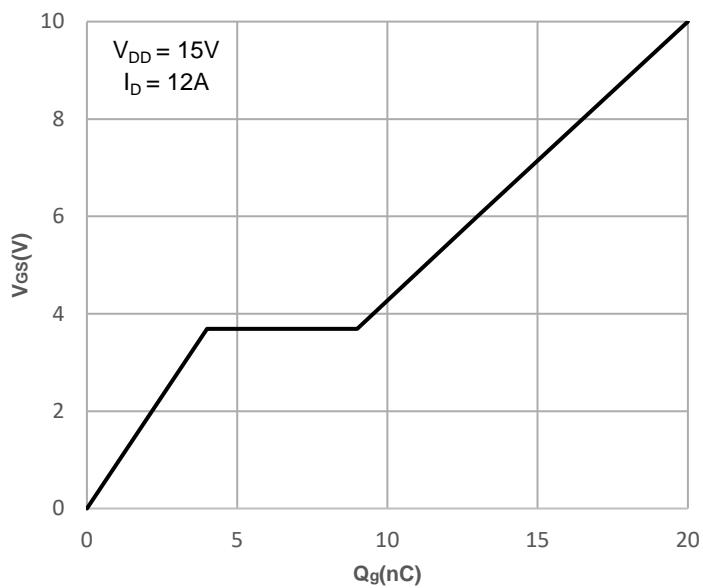
**Figure 3: On-resistance vs. Drain Current**



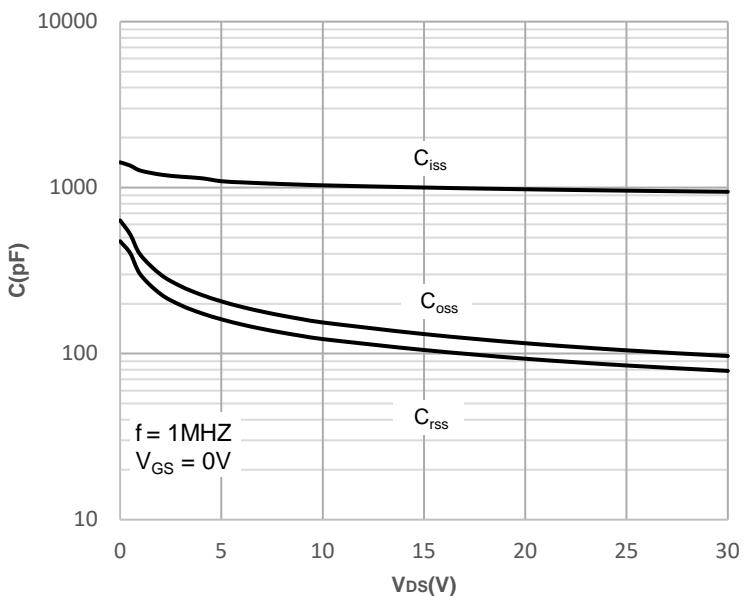
**Figure 4: Body Diode Characteristics**



**Figure 5: Gate Charge Characteristics**

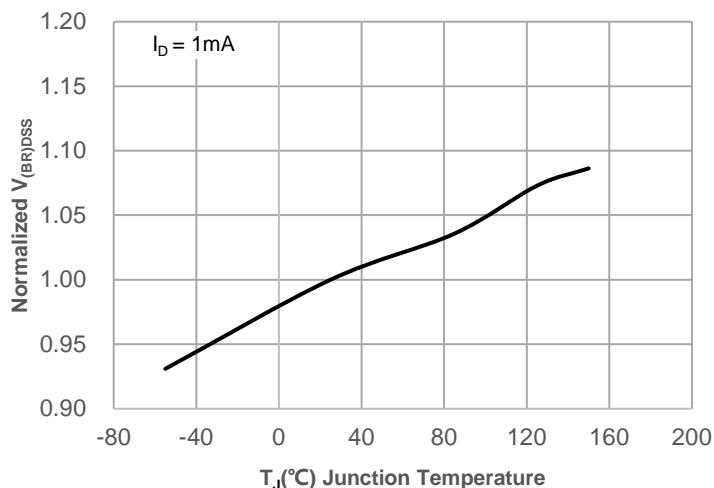


**Figure 6: Capacitance Characteristics**

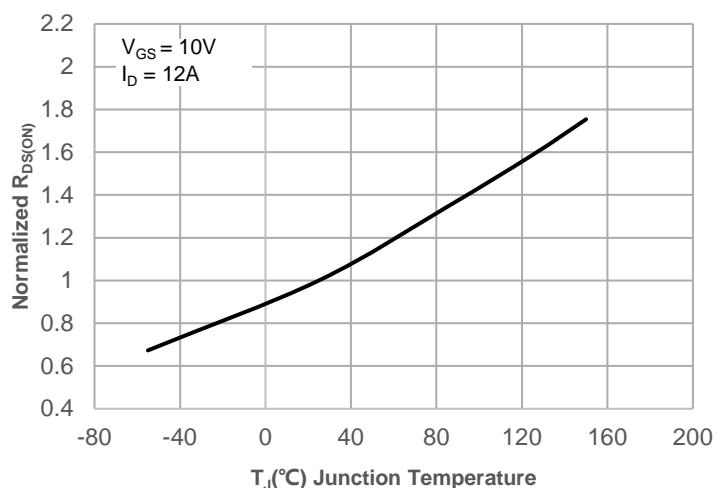


## Typical Performance Characteristics

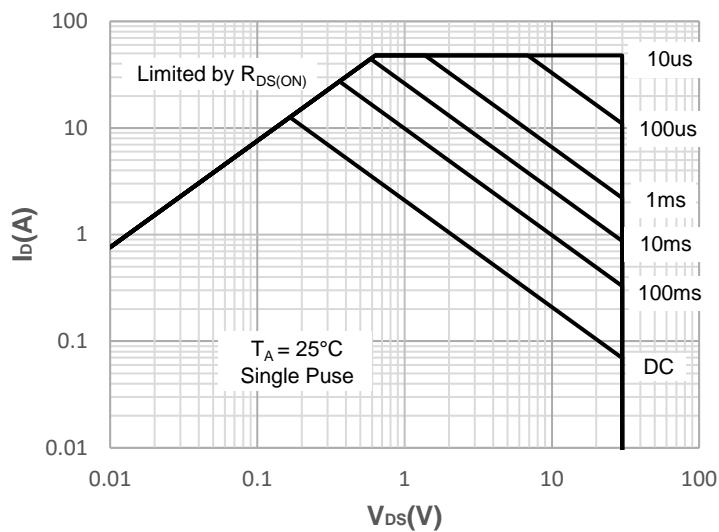
**Figure 7: Normalized Breakdown voltage vs. Junction Temperature**



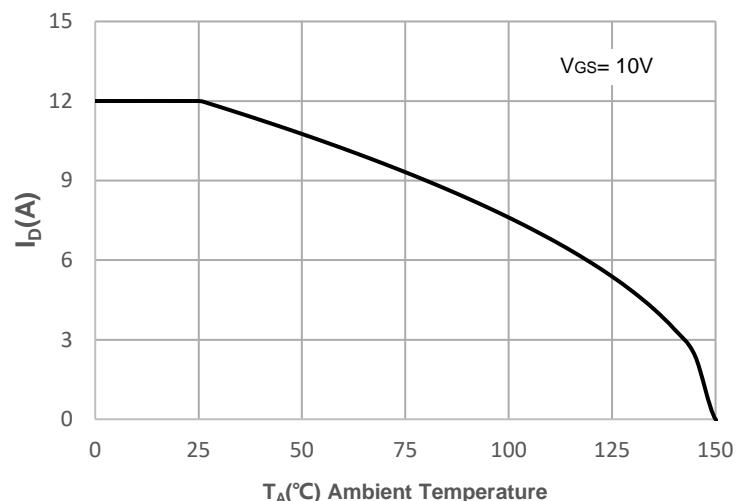
**Figure 8: Normalized on Resistance vs. Junction Temperature**



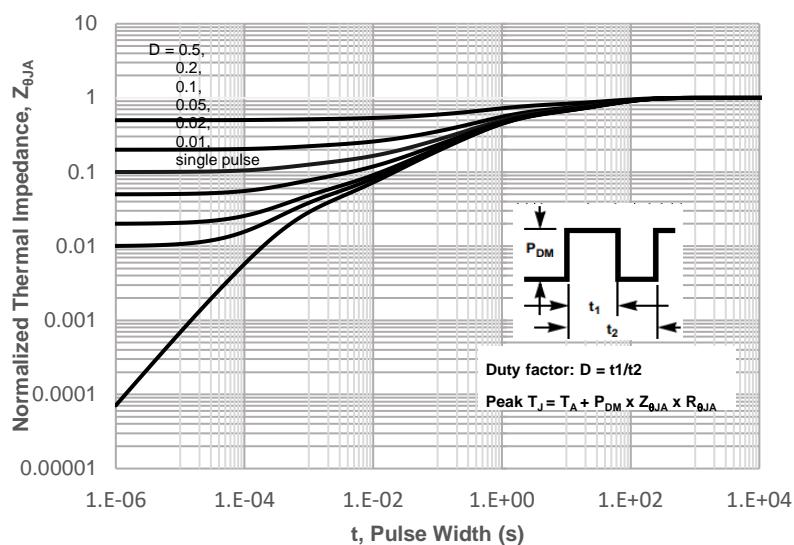
**Figure 9: Maximum Safe Operating Area**



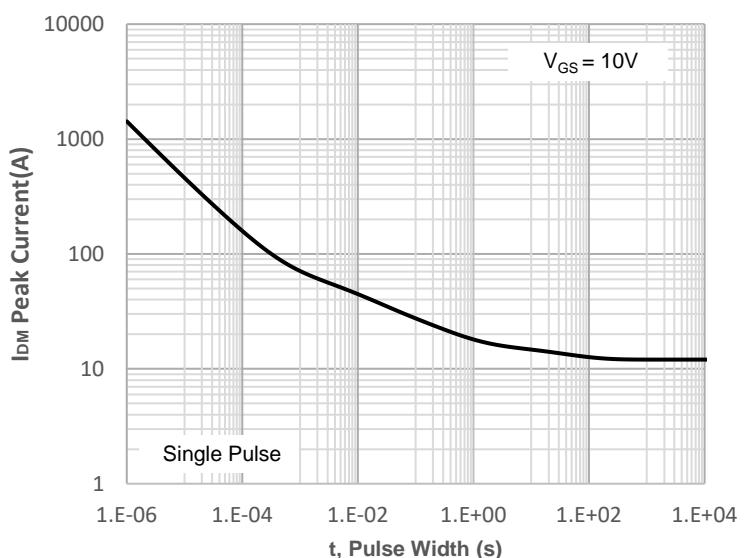
**Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature**



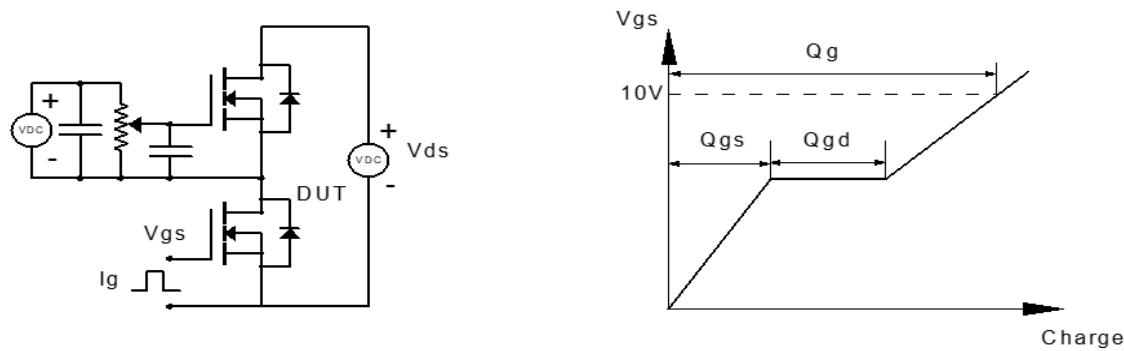
**Figure 11: Normalized Maximum Transient Thermal Impedance**



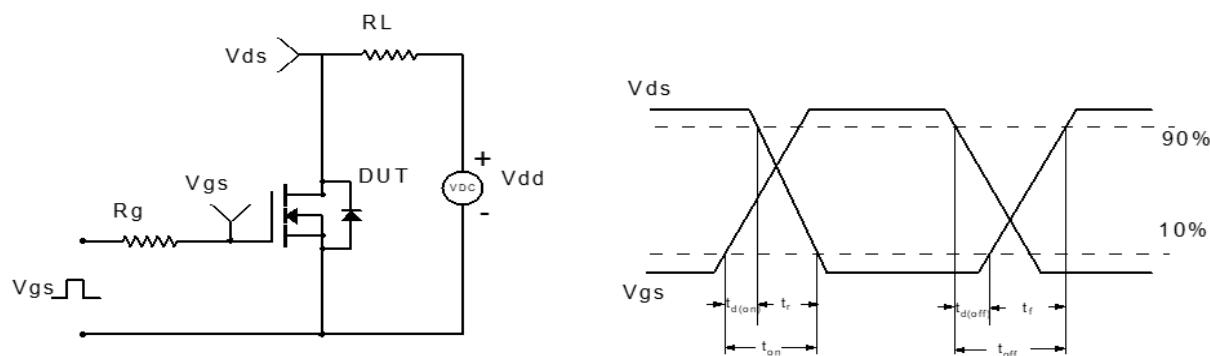
**Figure 12: Peak Current Capacity**



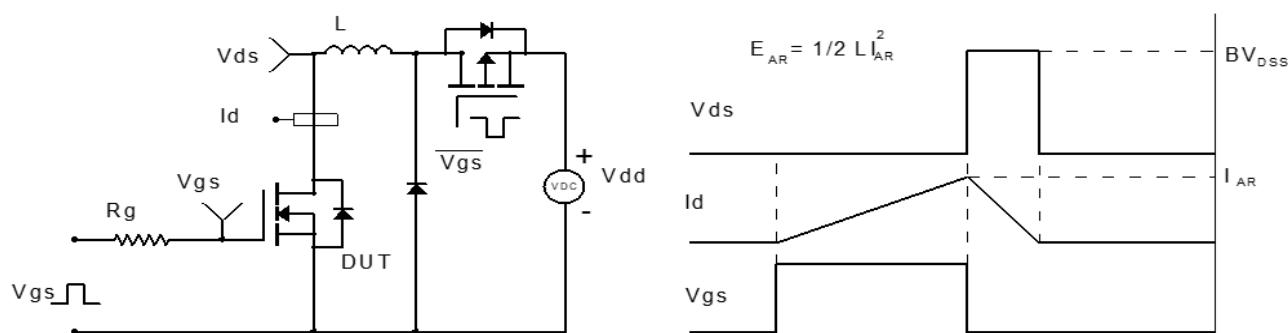
## Test Circuit



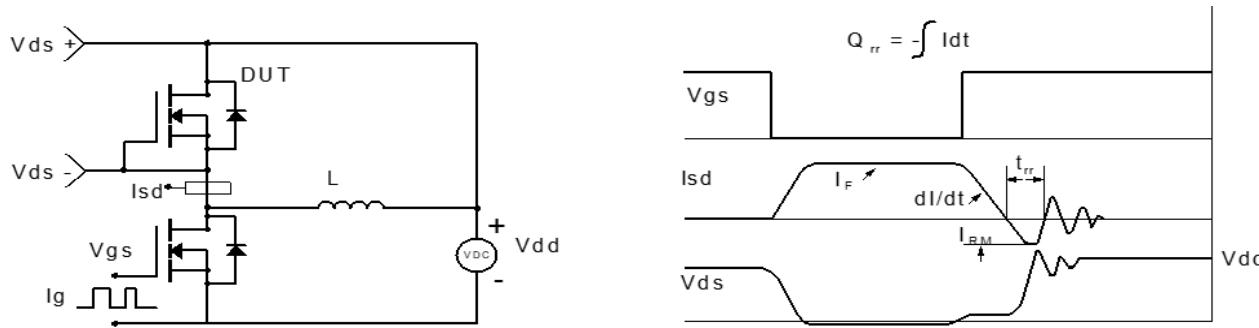
**Figure 1: Gate Charge Test Circuit & Waveform**



**Figure 2: Resistive Switching Test Circuit & Waveform**

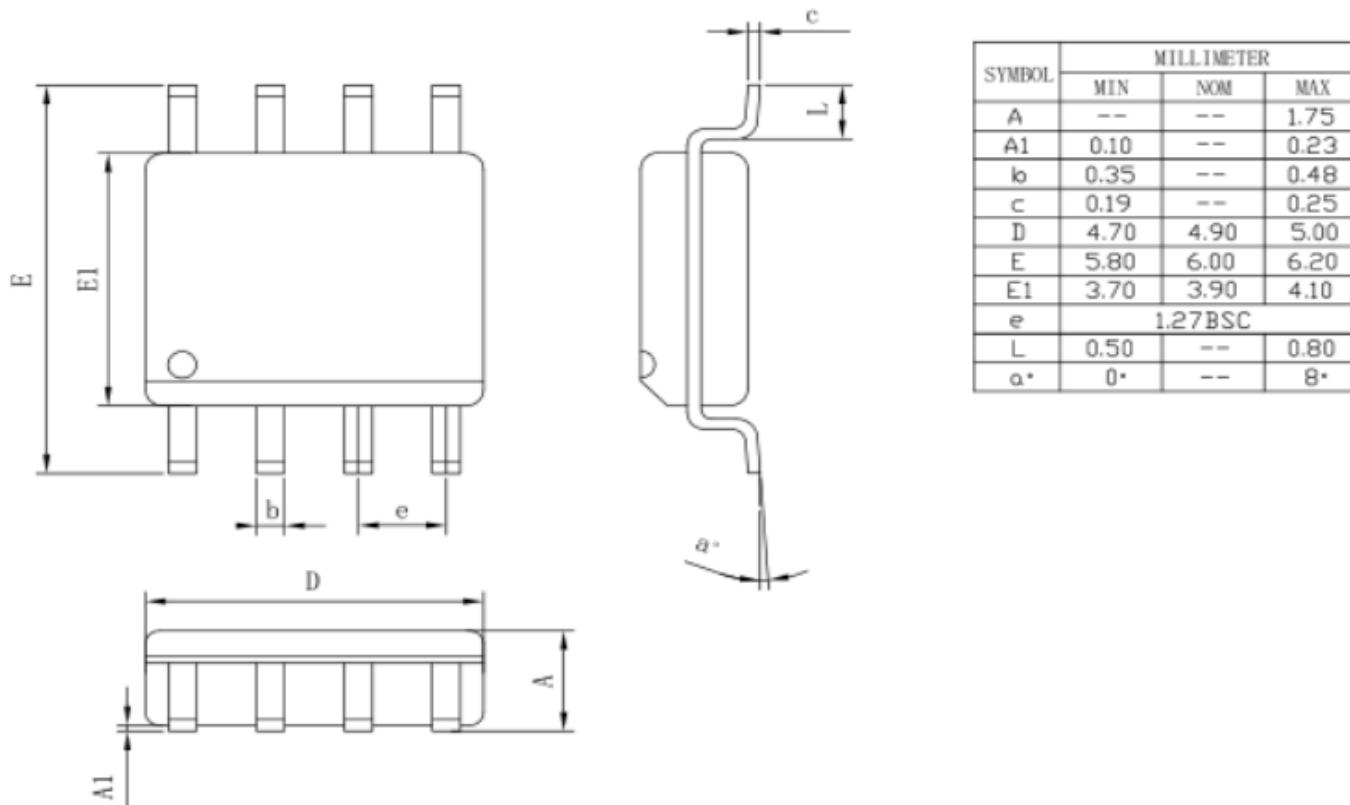


**Figure 3: Unclamped Inductive Switching Test Circuit & Waveform**



**Figure 4: Diode Recovery Test Circuit & Waveform**

## Package Mechanical Data(SOP-8)



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